



STL25N15F4

N-channel 150 V, 0.057 Ω , 6 A, PowerFLAT™(5x6)
STripFET™ DeepGATE™ Power MOSFET

Features

| Type | V _{DSS} | R _{DS(on) max} | I _D |
|------------|------------------|-------------------------|----------------|
| STL25N15F4 | 150 V | < 0.063 Ω | 6 A |

- N-channel enhancement mode
- 100% avalanched rated
- Low gate charge
- Very low on-resistance

Application

- Switching applications

Description

This STripFET™ DeepGATE™ Power MOSFET technology is among the latest improvements, which have been especially tailored to minimize on-state resistance, with a new gate structure, providing superior switching performance.

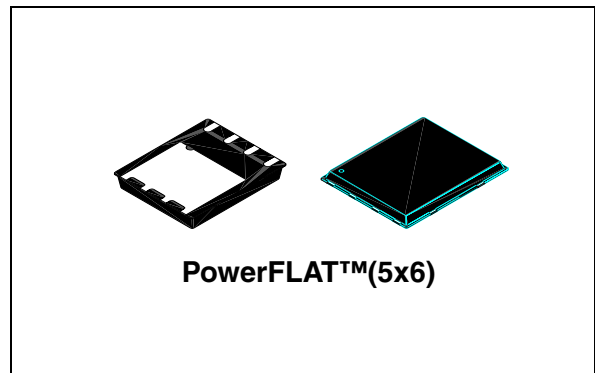


Figure 1. Internal schematic diagram

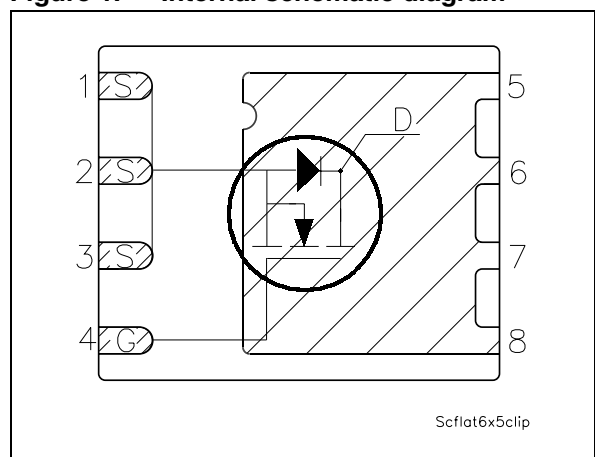


Table 1. Device summary

| Order code | Marking | Package | Packaging |
|------------|---------|------------------|---------------|
| STL25N15F4 | 25N15F4 | PowerFLAT™ (5x6) | Tape and reel |

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1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|-----------------|---|------------|------------------|
| V_{DS} | Drain-source voltage ($V_{GS} = 0$) | 150 | V |
| V_{GS} | Gate-source voltage | ± 20 | V |
| $I_D^{(1)}$ | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$ | 25 | A |
| $I_D^{(2)}$ | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$ | 6 | A |
| $I_D^{(2)}$ | Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$ | 3.75 | A |
| $I_{DM}^{(3)}$ | Drain current (pulsed) | 24 | A |
| $P_{TOT}^{(1)}$ | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$ | 80 | W |
| $P_{TOT}^{(2)}$ | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$ | 4 | W |
| T_{stg} | Storage temperature | -55 to 150 | $^\circ\text{C}$ |
| T_j | Operating junction temperature | | |

1. The value is rated according to R_{thj-c}
2. The value is rated according to $R_{thj-pcb}$
3. Pulse width limited by safe operating area

Table 3. Thermal data

| Symbol | Parameter | Value | Unit |
|---------------------|---|-------|---------------------------|
| $R_{thj-pcb}^{(1)}$ | Thermal resistance junction-pcb max | 31.3 | $^\circ\text{C}/\text{W}$ |
| $R_{thj-case}$ | Thermal resistance junction-case (drain) (steady state) max. | 1.56 | $^\circ\text{C}/\text{W}$ |

1. When mounted on FR-4 board of 1 inch², 2 oz Cu, $t < 10$ sec

Table 4. Avalanche characteristics

| Symbol | Parameter | Max value | Unit |
|----------|---|-----------|------|
| I_{AS} | Avalanche current, repetitive or not-repetitive (pulse width limited by T_j max) | 12.5 | A |
| E_{AS} | Single pulse avalanche energy (starting $T_j = 25\text{ }^\circ\text{C}$, $I_D = I_{AS}$, $V_{DD} = 50\text{ V}$) | 125 | mJ |

2 Electrical characteristics

($T_J = 25\text{ °C}$ unless otherwise specified)

Table 5. On/off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|--|--|------|-------|-----------|--------------------------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $I_D = 1\text{ mA}$, $V_{GS} = 0$ | 150 | | | V |
| I_{DSS} | Zero gate voltage drain current ($V_{GS} = 0$) | $V_{DS} = 150\text{ V}$, $V_{DS} = 150\text{ V}$, @ 125 °C | | | 1 10 | μA μA |
| I_{GSS} | Gate body leakage current ($V_{DS} = 0$) | $V_{GS} = \pm 20\text{ V}$ | | | ± 100 | nA |
| $V_{GS(th)}$ | Gate threshold voltage | $V_{DS} = V_{GS}$, $I_D = 250\text{ }\mu\text{A}$ | 2 | | 4 | V |
| $R_{DS(on)}$ | Static drain-source on resistance | $V_{GS} = 10\text{ V}$, $I_D = 3\text{ A}$ | | 0.057 | 0.063 | Ω |

Table 6. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|---|------|------|------|----------|
| C_{iss} | Input capacitance | $V_{DS} = 25\text{ V}$, $f = 1\text{ MHz}$, $V_{GS} = 0$ | - | 2710 | - | pF |
| C_{oss} | Output capacitance | | | 180 | | pF |
| C_{rss} | Reverse transfer capacitance | | | 69.5 | | pF |
| Q_g | Total gate charge | $V_{DD} = 75\text{ V}$, $I_D = 6\text{ A}$ $V_{GS} = 10\text{ V}$ (see Figure 14) | - | 48 | - | nC |
| Q_{gs} | Gate-source charge | | | 10.8 | | nC |
| Q_{gd} | Gate-drain charge | | | 13.7 | | nC |
| R_g | Gate input resistance | $f = 1\text{ MHz}$ Gate DC Bias=0 test signal level=20 mV open drain | - | 1.9 | - | Ω |

Table 7. Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--------------|---------------------|---|------|------|------|------|
| $t_{d(on)}$ | Turn-on delay time | $V_{DD} = 75\text{ V}$, $I_D = 3\text{ A}$, $R_G = 4.7\text{ }\Omega$, $V_{GS} = 10\text{ V}$ (see Figure 13) | - | 13.5 | - | ns |
| t_r | Rise time | | | 5.1 | | ns |
| $t_{d(off)}$ | Turn-off delay time | | | 39.7 | | ns |
| t_f | Fall time | | | 11.4 | | ns |

Table 8. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max | Unit |
|-----------------------------------|--|---|------|------------------|-----|---------------|
| I_{SD} | Source-drain current | | - | | 6 | A |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) | | - | | 24 | A |
| $V_{SD}^{(2)}$ | Forward on voltage | $I_{SD} = 6\text{ A}, V_{GS} = 0$ | - | | 1.3 | V |
| t_{rr} Q_{rr} I_{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD} = 6\text{ A},$ $di/dt = 100\text{ A}/\mu\text{s},$ $V_{DD} = 120\text{ V}, T_J = 150\text{ }^\circ\text{C}$ (see Figure 15) | - | 85 351 8.2 | | ns nC A |

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration=300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

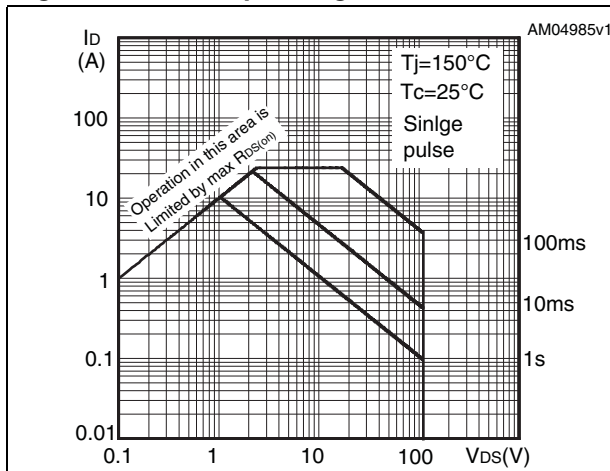


Figure 3. Thermal impedance

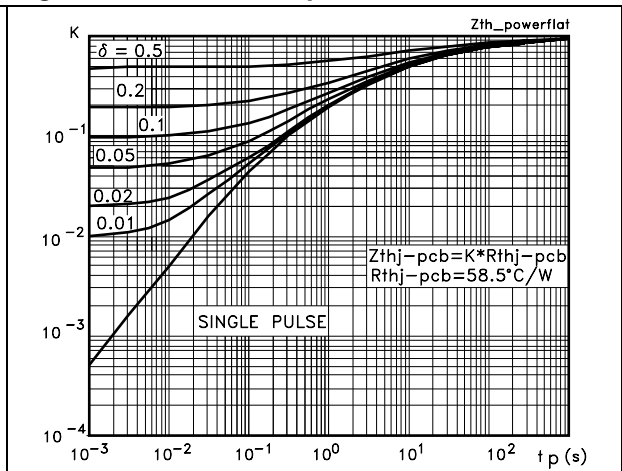


Figure 4. Output characteristics

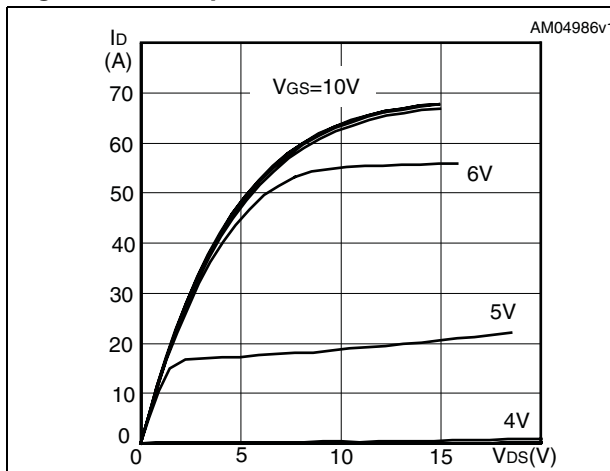


Figure 5. Transfer characteristics

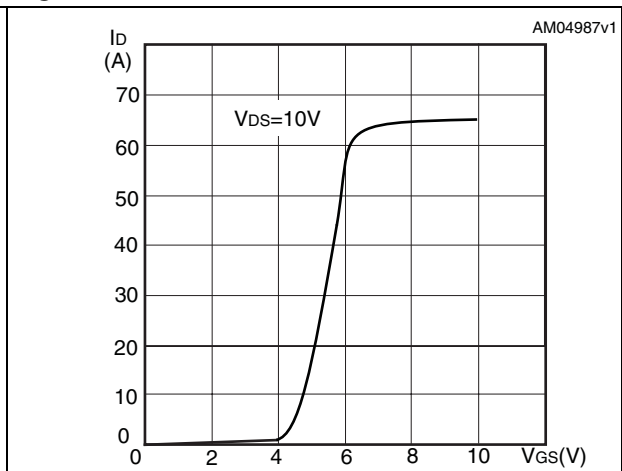


Figure 6. Normalized B_{VDS} vs temperature

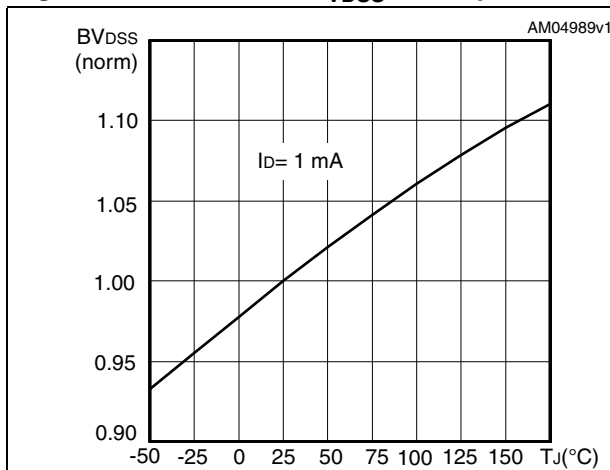


Figure 7. Static drain-source on resistance

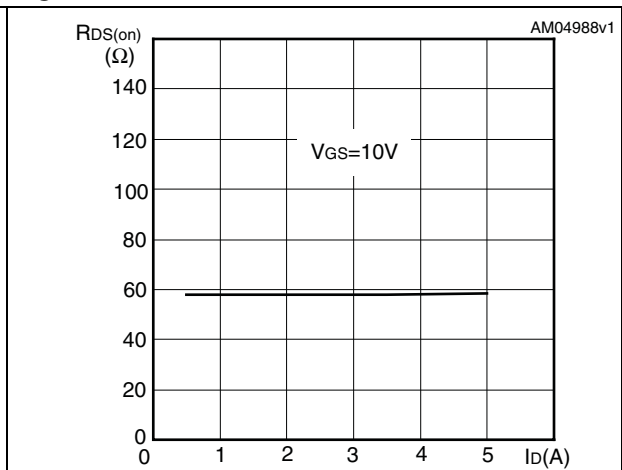


Figure 8. Gate charge vs gate-source voltage **Figure 9. Capacitance variations**

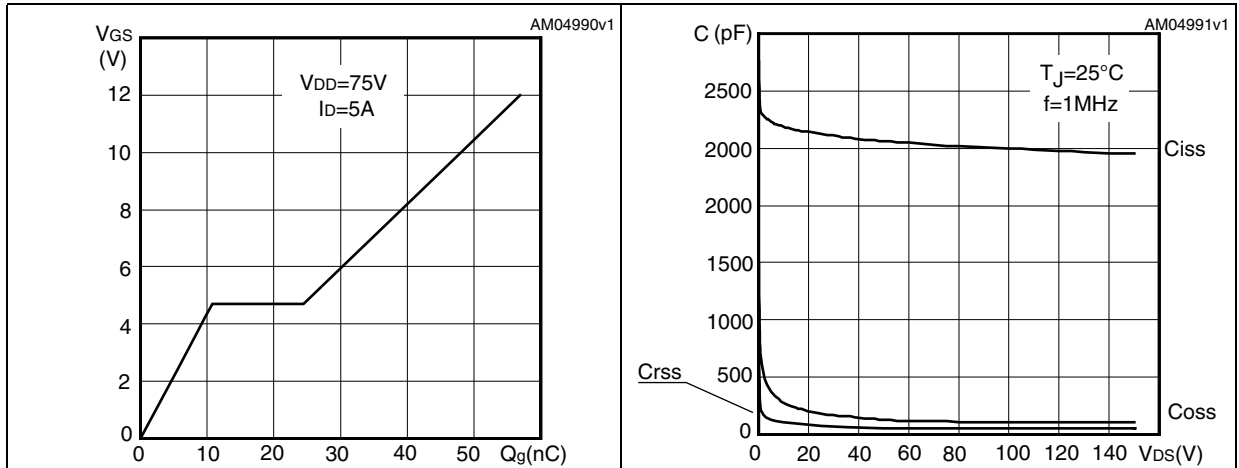


Figure 10. Normalized gate threshold voltage vs temperature **Figure 11. Normalized on resistance vs temperature**

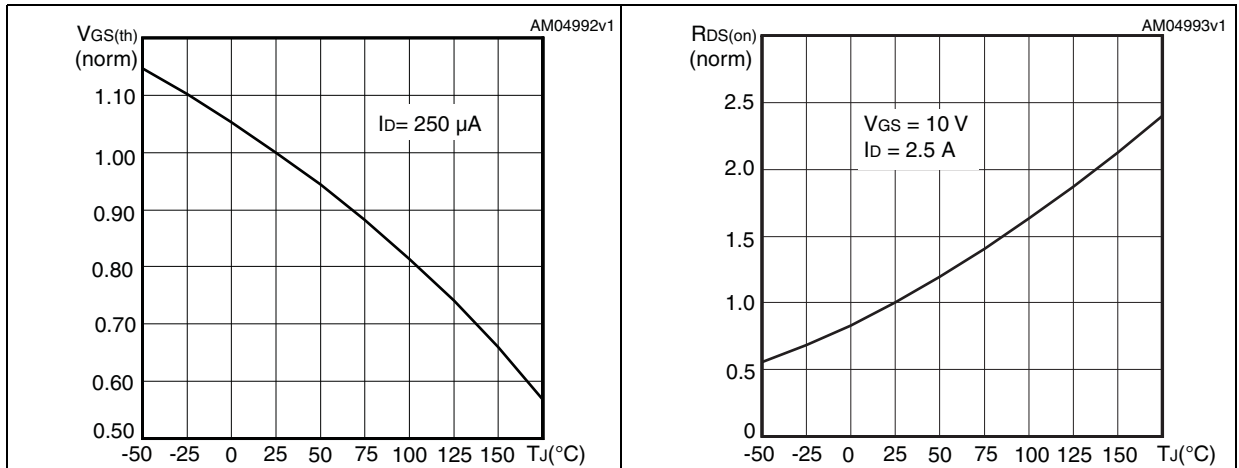
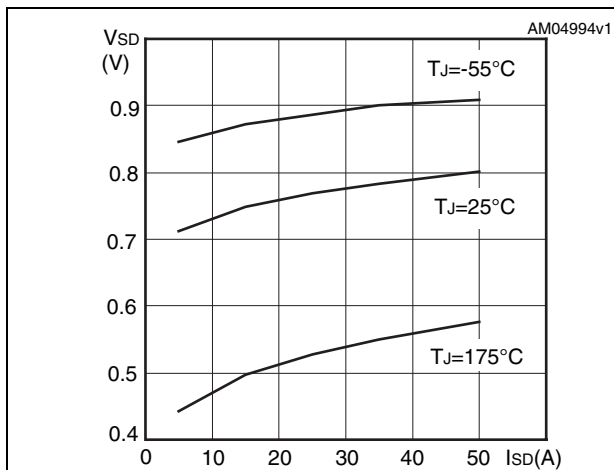
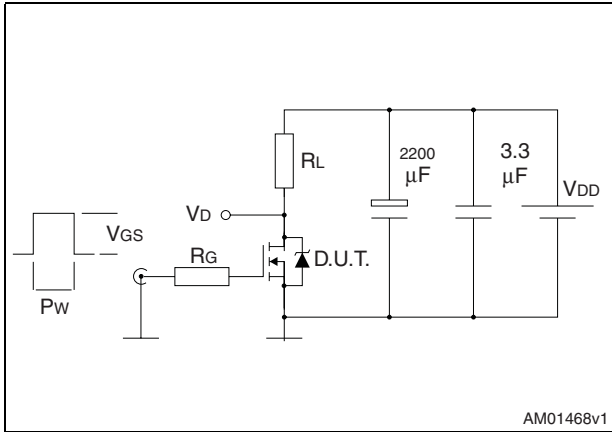


Figure 12. Source-drain diode forward characteristics



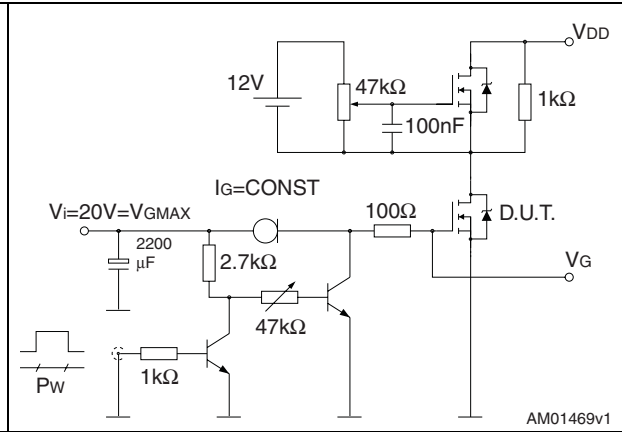
3 Test circuits

Figure 13. Switching times test circuit for resistive load



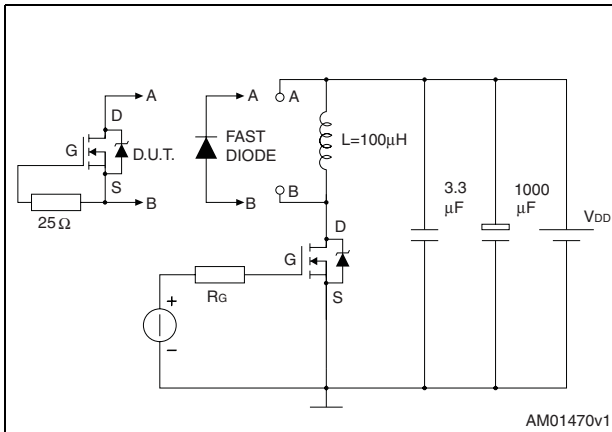
AM01468v1

Figure 14. Gate charge test circuit



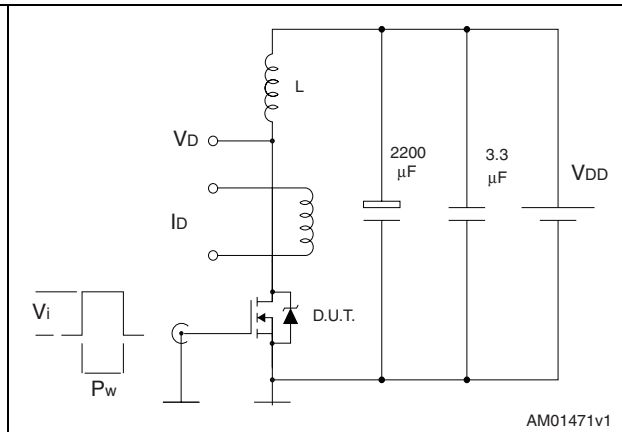
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Figure 15. Test circuit for inductive load switching and diode recovery times



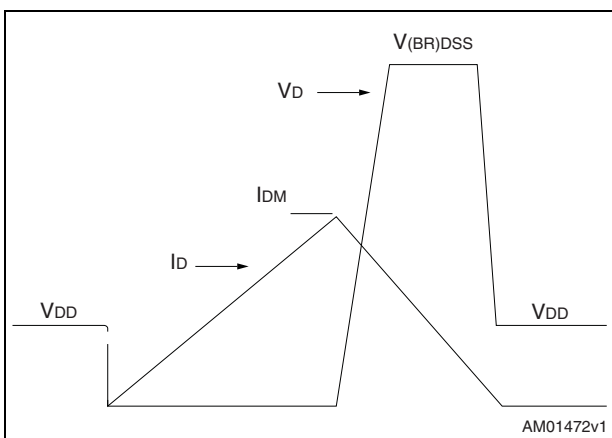
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Figure 16. Unclamped inductive load test circuit



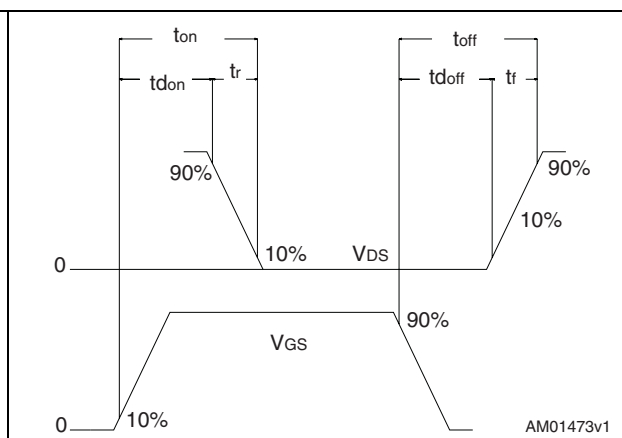
AM01471v1

Figure 17. Unclamped inductive waveform



AM01472v1

Figure 18. Switching time waveform



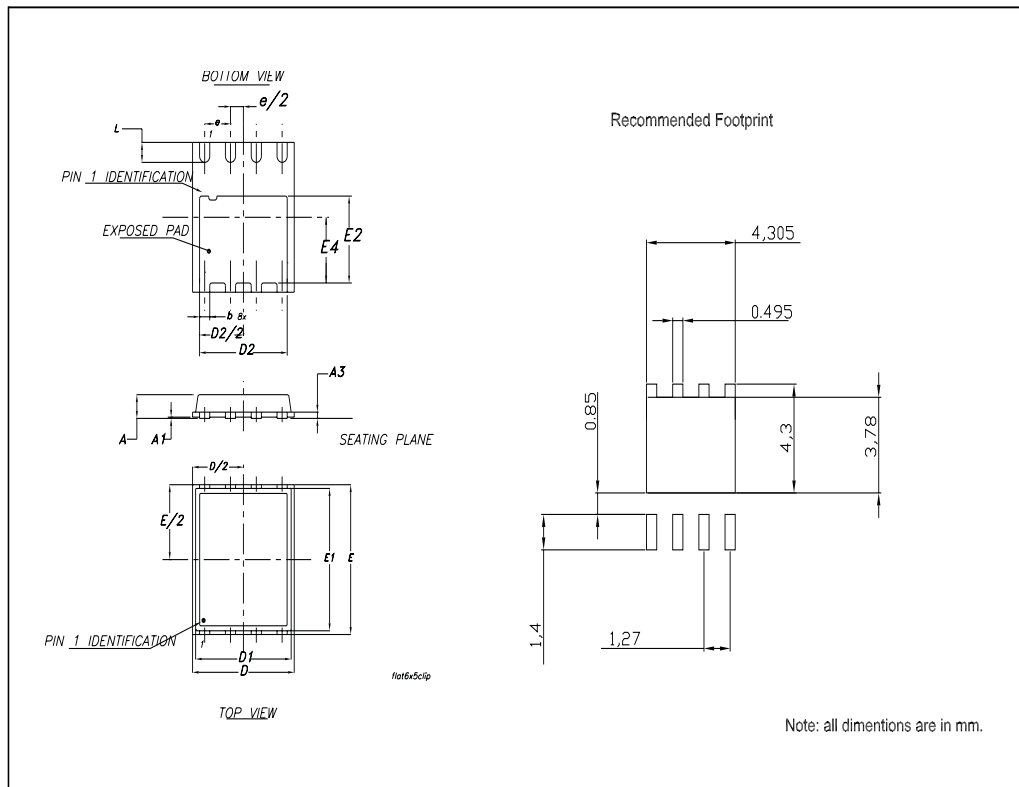
AM01473v1

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

PowerFLAT™ (5x6) MECHANICAL DATA

| DIM. | mm. | | | inch | | |
|------|------|------|------|-------|--------|--------|
| | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| A | 0.80 | 0.83 | 0.93 | 0.031 | 0.032 | 0.036 |
| A1 | | 0.02 | 0.05 | | 0.0007 | 0.0019 |
| A3 | | 0.20 | | | 0.007 | |
| b | 0.35 | 0.40 | 0.47 | 0.013 | 0.015 | 0.018 |
| D | | 5.00 | | | 0.196 | |
| D1 | | 4.75 | | | 0.187 | |
| D2 | 4.15 | 4.20 | 4.25 | 0.163 | 0.165 | 0.167 |
| E | | 6.00 | | | 0.236 | |
| E1 | | 5.75 | | | 0.226 | |
| E2 | 3.43 | 3.48 | 3.53 | 0.135 | 0.137 | 0.139 |
| E4 | 2.58 | 2.63 | 2.68 | | 0.103 | 0.105 |
| e | | 1.27 | | | 0.050 | |
| L | 0.70 | 0.80 | 0.90 | 0.027 | 0.031 | 0.035 |



5 Revision history

Table 9. Document revision history

| Date | Revision | Changes |
|-------------|----------|---------------|
| 09-Sep-2009 | 1 | First release |

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